

MOSFET - Power, Single **N-Channel**

80 V, 20.7 mΩ, 32 A

NVMFS6H858N

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- NVMFS6H858NWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

| Parar | Symbol | Value | Unit | | |
|---|-----------------|----------------------------|-----------------------------------|----------------|----|
| Drain-to-Source Voltage | | | V_{DSS} | 80 | V |
| Gate-to-Source Voltage | 9 | | V_{GS} | ±20 | V |
| Continuous Drain | Steady | T _C = 25°C | I _D | 29 | Α |
| Current R _{θJC} (Notes 1, 3) | State | T _C = 100°C | | 21 | |
| Power Dissipation | | T _C = 25°C | P_{D} | 42 | W |
| R _{θJC} (Note 1) | | T _C = 100°C | | 21 | |
| Continuous Drain | Steady State | T _A = 25°C | I _D | 8.4 | Α |
| Current R _{0JA} (Notes 1, 2, 3) | Siale | T _A = 100°C | | 6.0 | |
| Power Dissipation | | T _A = 25°C | P_{D} | 3.5 | W |
| R _{θJA} (Notes 1, 2) | | T _A = 100°C | | 1.8 | |
| Pulsed Drain Current | $T_A = 25$ | °C, t _p = 10 μs | I _{DM} | 137 | Α |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | -55 to +175 | °C |
| Source Current (Body Diode) | | | Is | 35 | Α |
| Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 3.5 A) | | | E _{AS} | 151 | mJ |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | | T _L | 260 | °C |

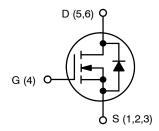
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|---|-----------------|-------|------|
| Junction-to-Case - Steady State | $R_{	heta JC}$ | 3.5 | °C/W |
| Junction-to-Ambient - Steady State (Note 2) | $R_{\theta JA}$ | 42.5 | |

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

| V _{(BR)DSS} | R _{DS(ON)} MAX | I _D MAX |
|----------------------|-------------------------|--------------------|
| 80 V | 20.7 mΩ @ 10 V | 32 A |



N-CHANNEL MOSFET

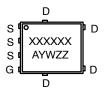






(FULL-CUT SO8FL WF) CASE 507BA

MARKING DIAGRAM



XXXXXX = 6H858N

(NVMFS6H858N) or

858NWF

(NVMFS6H858NWF)

= Assembly Location Α

= Year = Work Week

W 77 = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

| Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit |
|--|-------------------------------------|---|--------------------------|-----|------|------|-------|
| OFF CHARACTERISTICS | | | | | | • | |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | | 80 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} / | | | | 44 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} = 0 V, | T _J = 25 °C | | | 10 | μΑ |
| | | V _{DS} = 80 V | T _J = 125°C | | | 250 | |
| Gate-to-Source Leakage Current | I _{GSS} | V _{DS} = 0 V, V _{GS} = 20 V | V | | | 100 | nA |
| ON CHARACTERISTICS (Note 4) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_{D} = 30 \mu$ | A | 2.0 | | 4.0 | V |
| Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | -7.5 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 5 A | | 16.9 | 20.7 | mΩ |
| Forward Transconductance | 9 _F s | V _{DS} =15 V, I _D = 10 A | | | 36 | | S |
| CHARGES, CAPACITANCES & GATE RE | SISTANCE | | | | | | |
| Input Capacitance | C _{ISS} | V _{GS} = 0 V, f = 1 MHz, V _{DS} = 40 V | | | 510 | | pF |
| Output Capacitance | C _{OSS} | | | | 80 | | 1 |
| Reverse Transfer Capacitance | C _{RSS} | | | | 4.7 | | 1 |
| Total Gate Charge | Q _{G(TOT)} | V _{GS} = 10 V, V _{DS} = 40 | V; I _D = 10 A | | 8.9 | | nC |
| Threshold Gate Charge | Q _{G(TH)} | V _{GS} = 10 V, V _{DS} = 40 V; I _D = 10 A | | | 2.2 | | 1 |
| Gate-to-Source Charge | Q _{GS} | | | | 2.8 | | 1 |
| Gate-to-Drain Charge | Q_{GD} | | | | 1.7 | | 1 |
| Plateau Voltage | V_{GP} | | | | 4.8 | | V |
| SWITCHING CHARACTERISTICS (Note | 5) | | | | • | • | |
| Turn-On Delay Time | t _{d(ON)} | $V_{GS} = 10 \text{ V}, V_{DS} = 64$ | | | 8.0 | | ns |
| Rise Time | t _r | I_D = 10 A, R_G = 2.5 Ω | | | 17 | | |
| Turn-Off Delay Time | t _{d(OFF)} | | | | 19 | | |
| Fall Time | t _f | | | | 13 | | 1 |
| DRAIN-SOURCE DIODE CHARACTERIS | STICS | | | | • | | - |
| Forward Diode Voltage | V _{SD} | V _{GS} = 0 V, | T _J = 25°C | | 0.8 | 1.2 | V |
| | | I _S = 5 A | T _J = 125°C | | 0.7 | | |
| Reverse Recovery Time | t _{RR} | V _{GS} = 0 V, dIS/dt = 100 A/μs, I _S = 10 A | | | 29 | | ns |
| Charge Time | ta | | | | 19 | | |
| Discharge Time | t _b | | | | 9.0 | | |
| Reverse Recovery Charge | Q _{RR} | | | | 23 | | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

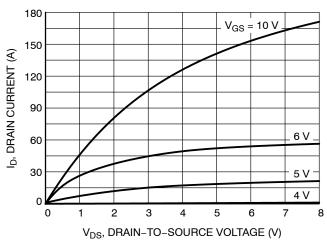


Figure 1. On-Region Characteristics

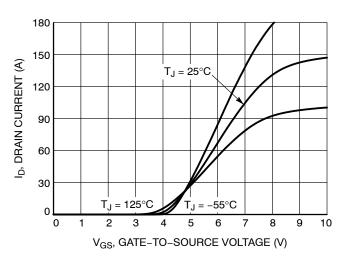


Figure 2. Transfer Characteristics

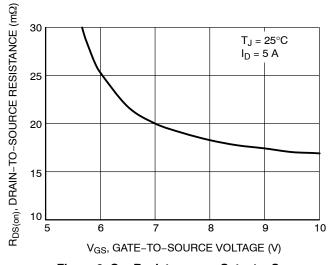


Figure 3. On-Resistance vs. Gate-to-Source Voltage

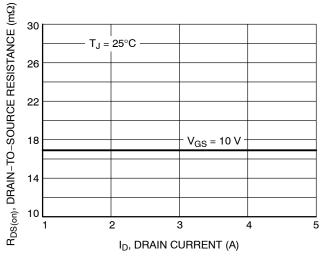


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

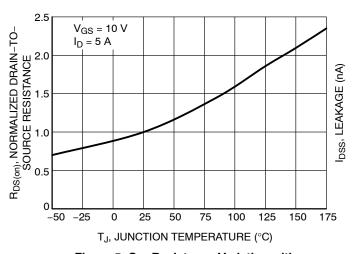


Figure 5. On–Resistance Variation with Temperature

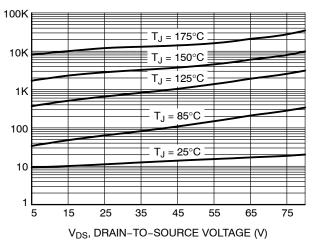


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS (Continued)

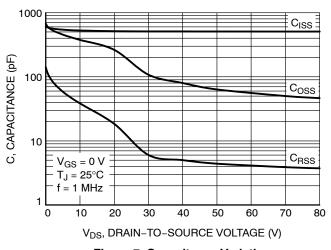


Figure 7. Capacitance Variation

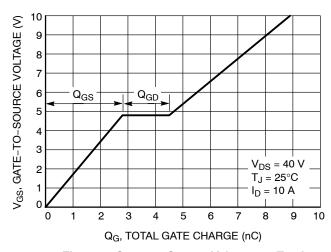


Figure 8. Gate-to-Source Voltage vs. Total Charge

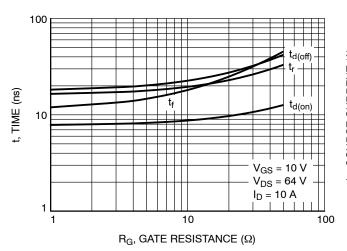


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

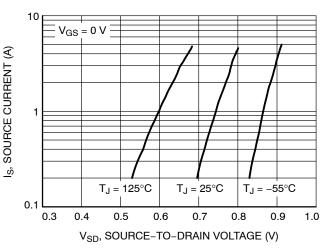


Figure 10. Diode Forward Voltage vs. Current

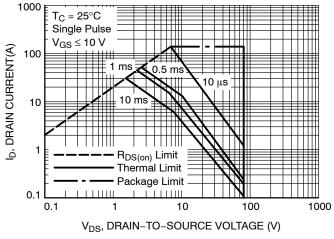


Figure 11. Maximum Rated Forward Biased Safe Operating Area

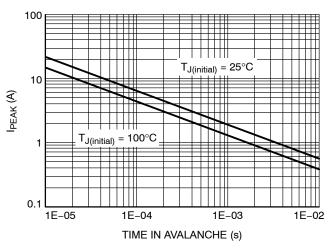


Figure 12. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS (Continued)

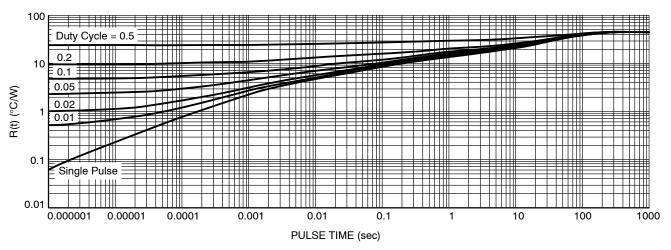


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

| Device | Marking | Package | Shipping [†] |
|------------------|---------|-------------------------------------|-----------------------|
| NVMFS6H858NT1G | 6H858N | DFN5 (Pb-Free) | 1500 / Tape & Reel |
| NVMFS6H858NWFT1G | 858NWF | DFNW5 (Pb-Free, Wettable Flanks) | 1500 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



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SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

DATE 25 JUN 2018

NOTES:

BURRS

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE

| | MILLIMETERS | | | | |
|-----|-------------|----------|------|--|--|
| DIM | MIN | NOM | MAX | | |
| Α | 0.90 | 1.00 | 1.10 | | |
| A1 | 0.00 | | 0.05 | | |
| b | 0.33 | 0.41 | 0.51 | | |
| С | 0.23 | 0.28 | 0.33 | | |
| D | 5.00 | 5.15 | 5.30 | | |
| D1 | 4.70 | 4.90 | 5.10 | | |
| D2 | 3.80 | 4.00 | 4.20 | | |
| E | 6.00 | 6.15 | 6.30 | | |
| E1 | 5.70 | 5.90 | 6.10 | | |
| E2 | 3.45 | 3.65 | 3.85 | | |
| е | | 1.27 BSC | | | |
| G | 0.51 | 0.575 | 0.71 | | |
| K | 1.20 | 1.35 | 1.50 | | |
| L | 0.51 | 0.575 | 0.71 | | |
| L1 | 0.125 REF | | | | |
| М | 3.00 | 3.40 | 3.80 | | |
| A | 0 0 | | 12 ° | | |

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

| DOCUMENT NUMBER: | 98AON14036D | Electronic versions are uncontrolled except when accessed directly from the Document Rep Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red. | |
|------------------|--------------------------|---|-------------|
| DESCRIPTION: | DFN5 5x6, 1.27P (SO-8FL) | | PAGE 1 OF 1 |

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PIN 1

IDENTIFIER

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DFNW5 5x6 (FULL-CUT SO8FL WF)

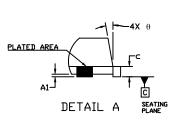
CASE 507BA **ISSUE A**

DATE 03 FEB 2021

MILLIMETERS



DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
CONTROLLING DIMENSION: MILLIMETERS
DIMENSIONS DI AND EI DO NOT INCLUDE MOLD FLASH,
PROTRUSIONS, OR GATE BURRS.
THIS PACKAGE CONTAINS WETTABLE FLANK DESIGN
FEATURES TO AID IN FILLET FORMATION ON THE LEADS
DURING MULINITING DURING MOUNTING.



| DIM | MIN. | N□M. | MAX. |
|-----|-----------|-------|------|
| Α | 0.90 | 1.00 | 1.10 |
| A1 | 0.00 | | 0.05 |
| b | 0.33 | 0.41 | 0.51 |
| c | 0.23 | 0.28 | 0.33 |
| D | 5.00 | 5.15 | 5.30 |
| D1 | 4.70 | 4.90 | 5.10 |
| D2 | 3.80 | 4.00 | 4.20 |
| E | 6.00 | 6.15 | 6.30 |
| E1 | 5.70 | 5.90 | 6.10 |
| E2 | 3.45 | 3.65 | 3.85 |
| e | 1.27 BSC | | |
| G | 0.51 | 0.575 | 0.71 |
| K | 1.20 | 1.35 | 1.50 |
| L | 0.51 | 0.575 | 0.71 |
| L1 | 0.150 REF | | |
| | | | |

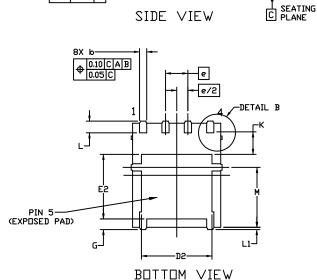
3.40

3.80

12*

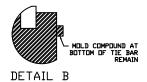
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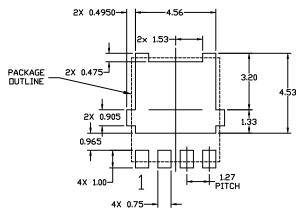
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TOP VIEW

DETAIL A





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RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the $\square N$ Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



= Assembly Location Α

Υ = Year

77

W

= Work Week = Lot Traceability

XXXXXX = Specific Device Code *This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products

may not follow the Generic Marking.

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